

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/066,363	FINSTER ET AL.	
Examiner		Art Unit		Page 1 of 1
Annan Q. Shang		2623		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0049574	03-2004	Watson et al.	709/224
*	B	US-6,985,190	01-2006	Klopfenstein et al.	348/569
*	C	US-6,715,129	03-2004	Hind et al.	715/513
*	D	US-6,513,069	01-2003	Abato et al.	709/238
*	E	US-6,345,279	02-2002	Li et al.	707/104.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.